Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
	Reexamination

10511456 PAYNE, PATRICK

2455

Examiner Art Unit

SEARCHED

Kim, Edward J

Class	Subclass	Date	Examiner
709	201-253		Edward J Kim
379	200-207		Edward J Kim
455	1-575.9		Edward J Kim

SEARCH NOTES

Search Notes	Date	Examiner
Also searched the Derwent, JPO, EPO, and IBM databases		Edward J Kim
Also conducted inventor search on Patrick Payne		Edward J Kim
Updated East Search	10/18/2007	EJK
Discussed with SPE	10/18/2007	EJK
Updated search.	07/11/2008	EJK
Reviewed case according to the Amendment	05/01/2009	EJK
Reviewed case according to the amendment	08/28/2009	EJK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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